

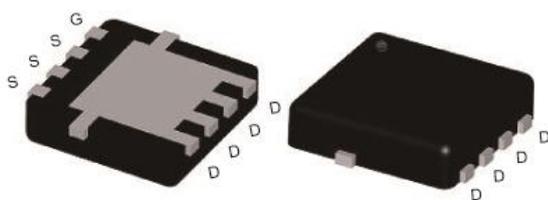
**N-Channel 30V(D-S) Enhancement MOSFET**

**GENERAL DESCRIPTION**

The ME7114S-G is the N-Channel logic enhancement mode power field effect transistors are produced using high cell density , DMOS trench technology. This high density process is especially tailored to minimize on-state resistance. These devices are particularly suited for low voltage application such as cellular phone and notebook computer power management and other battery powered circuits where Low-side switching , and low in-line power loss are needed in a very small outline surface mount package.

**PIN CONFIGURATION**

DFN(S) 3x3  
Top View

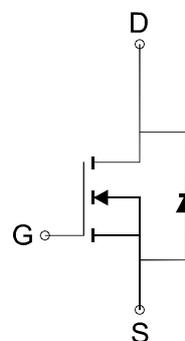


**FEATURES**

- $R_{DS(ON)} \leq 7m\Omega @ V_{GS}=10V$
- $R_{DS(ON)} \leq 10.5m\Omega @ V_{GS}=4.5V$
- Super high density cell design for extremely low  $R_{DS(ON)}$
- Exceptional on-resistance and maximum DC current capability

**APPLICATIONS**

- Portable Equipment
- Battery Powered System
- DC/DC Converter
- Load Switch



N-Channel MOSFET

Ordering Information: ME7114S-G (Green product-Halogen free)

**Absolute Maximum Ratings (TA=25°C Unless Otherwise Noted)**

| Parameter                               |                  | Symbol          | Maximum Ratings |     |     | Unit |
|-----------------------------------------|------------------|-----------------|-----------------|-----|-----|------|
| Drain-Source Voltage                    |                  | $V_{DS}$        | 30              |     |     | V    |
| Gate-Source Voltage                     |                  | $V_{GS}$        | $\pm 20$        |     |     | V    |
| Continuous Drain Current (Tj=150°C)*    | $T_C=25^\circ C$ | $I_D$           | 71              |     |     | A    |
|                                         | $T_C=70^\circ C$ |                 | 57              |     |     |      |
|                                         | $T_A=25^\circ C$ |                 | 18.4            |     |     |      |
|                                         | $T_A=70^\circ C$ |                 | 14.7            |     |     |      |
| Pulsed Drain Current                    |                  | $I_{DM}$        | 74              |     |     | A    |
| Maximum Power Dissipation*              | $T_C=25^\circ C$ | $P_D$           | 52              |     |     | W    |
|                                         | $T_C=70^\circ C$ |                 | 33              |     |     |      |
|                                         | $T_A=25^\circ C$ |                 | 3.8             |     |     |      |
|                                         | $T_A=70^\circ C$ |                 | 2.4             |     |     |      |
| Operating Junction Temperature          |                  | $T_J$           | -55 to 150      |     |     | °C   |
| Thermal Resistance-Junction to Ambient* |                  | $R_{\theta JA}$ | Typ             | 26  | Max | 33   |
| Thermal Resistance-Junction to Case*    |                  | $R_{\theta JC}$ | Typ             | 1.9 | Max | 2.4  |

\*The device mounted on 1in<sup>2</sup> FR4 board with 2 oz copper

## N-Channel 30V(D-S) Enhancement MOSFET

Electrical Characteristics (TA=25°C Unless Otherwise Specified)

| Symbol               | Parameter                                     | Limit                                                                                                        | Min | Typ  | Max  | Unit |
|----------------------|-----------------------------------------------|--------------------------------------------------------------------------------------------------------------|-----|------|------|------|
| <b>STATIC</b>        |                                               |                                                                                                              |     |      |      |      |
| V <sub>(BR)DSS</sub> | Drain-Source Breakdown Voltage                | V <sub>GS</sub> =0V, I <sub>D</sub> =250 μA                                                                  | 30  |      |      | V    |
| V <sub>GS(th)</sub>  | Gate Threshold Voltage                        | V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250 μA                                                    | 1.0 |      | 3.0  | V    |
| I <sub>GSS</sub>     | Gate Leakage Current                          | V <sub>DS</sub> =0V, V <sub>GS</sub> =±20V                                                                   |     |      | ±100 | nA   |
| I <sub>DSS</sub>     | Zero Gate Voltage Drain Current               | V <sub>DS</sub> =30V, V <sub>GS</sub> =0V                                                                    |     |      | 1    | μA   |
| R <sub>DS(ON)</sub>  | Drain-Source On-State Resistance <sup>a</sup> | V <sub>GS</sub> =10V, I <sub>D</sub> =13A                                                                    |     | 5.8  | 7    | mΩ   |
|                      |                                               | V <sub>GS</sub> =4.5V, I <sub>D</sub> =10A                                                                   |     | 8.5  | 10.5 |      |
| V <sub>SD</sub>      | Diode Forward Voltage                         | I <sub>S</sub> =2.8A, V <sub>GS</sub> =0V                                                                    |     | 0.75 | 1.1  | V    |
| <b>DYNAMIC</b>       |                                               |                                                                                                              |     |      |      |      |
| Q <sub>g</sub>       | Total Gate Charge                             | V <sub>DS</sub> =15V, V <sub>GS</sub> =10V, I <sub>D</sub> =13A                                              |     | 37   |      | nC   |
| Q <sub>g</sub>       | Total Gate Charge                             | V <sub>DS</sub> =15V, V <sub>GS</sub> =4.5V, I <sub>D</sub> =13A                                             |     | 18   |      |      |
| Q <sub>gs</sub>      | Gate-Source Charge                            |                                                                                                              |     | 7.7  |      |      |
| Q <sub>gd</sub>      | Gate-Drain Charge                             |                                                                                                              |     | 8.8  |      |      |
| C <sub>iss</sub>     | Input Capacitance                             | V <sub>DS</sub> =15V, V <sub>GS</sub> =0V,<br>F=1MHz                                                         |     | 1690 |      | pF   |
| C <sub>oss</sub>     | Output Capacitance                            |                                                                                                              |     | 260  |      |      |
| C <sub>rss</sub>     | Reverse Transfer Capacitance                  |                                                                                                              |     | 84   |      |      |
| R <sub>g</sub>       | Gate-Resistance                               | V <sub>DS</sub> =0V, V <sub>GS</sub> =0V, F=1MHz                                                             |     | 0.9  |      | Ω    |
| t <sub>d(on)</sub>   | Turn-On Delay Time                            | V <sub>DS</sub> =15V, R <sub>L</sub> =15Ω<br>I <sub>D</sub> =1A, V <sub>GEN</sub> =10V<br>R <sub>G</sub> =6Ω |     | 20   |      | ns   |
| t <sub>r</sub>       | Turn-On Rise Time                             |                                                                                                              |     | 16   |      |      |
| t <sub>d(off)</sub>  | Turn-Off Delay Time                           |                                                                                                              |     | 63   |      |      |
| t <sub>f</sub>       | Turn-Off Fall Time                            |                                                                                                              |     | 11   |      |      |

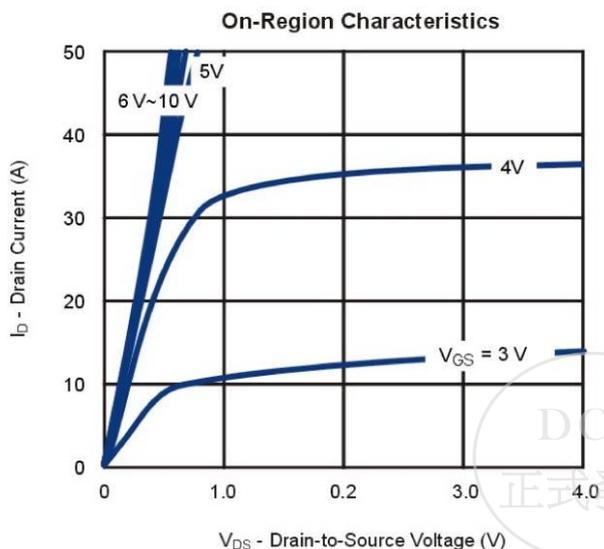
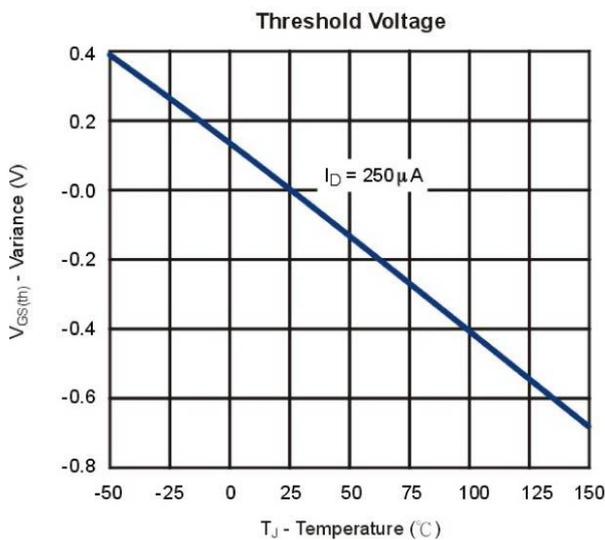
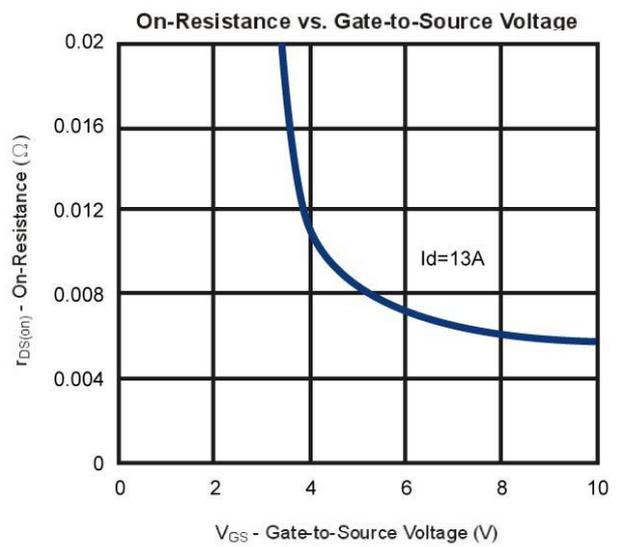
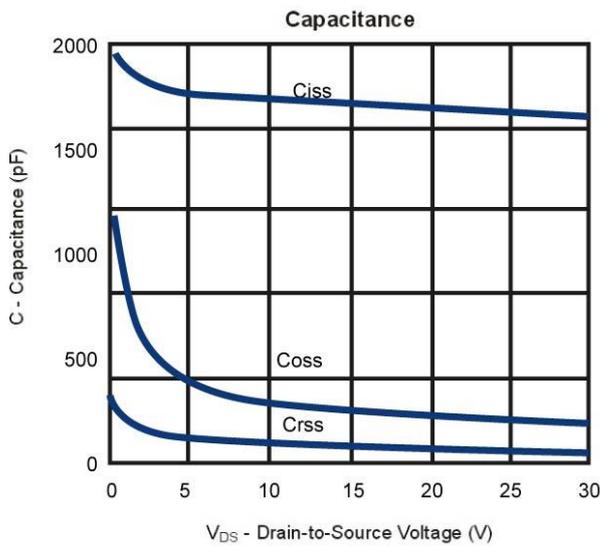
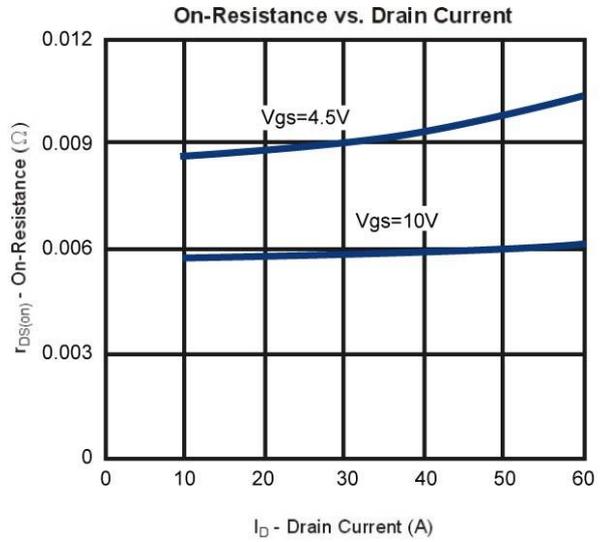
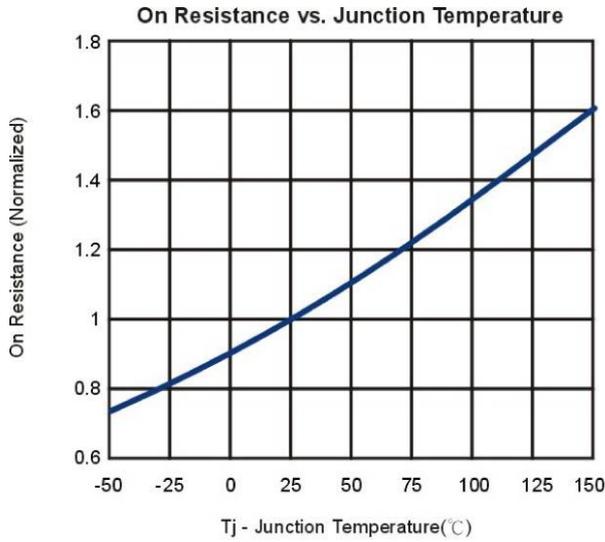
Note: a. Pulse test: pulse width ≤ 300us, duty cycle ≤ 2%

b. Matsuki Electric/ Force mos reserves the right to improve product design, functions and reliability without notice.



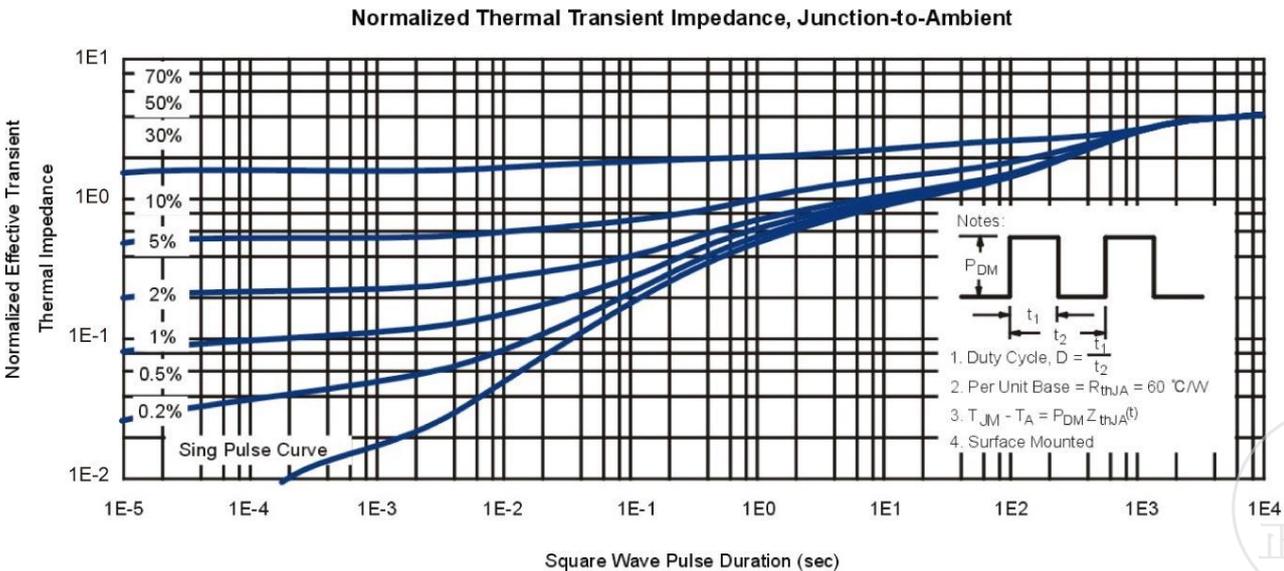
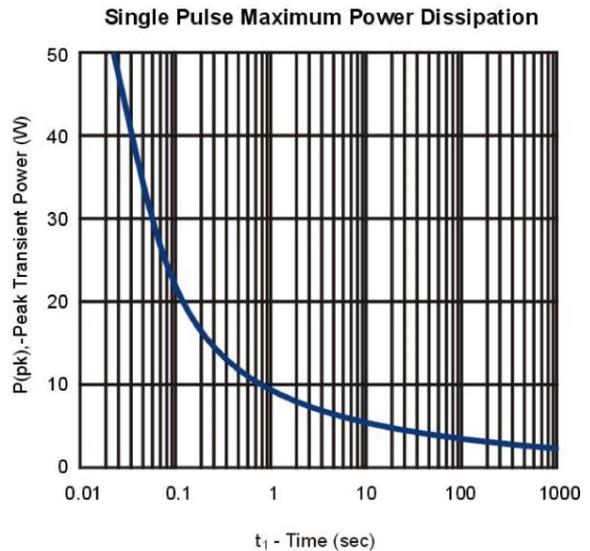
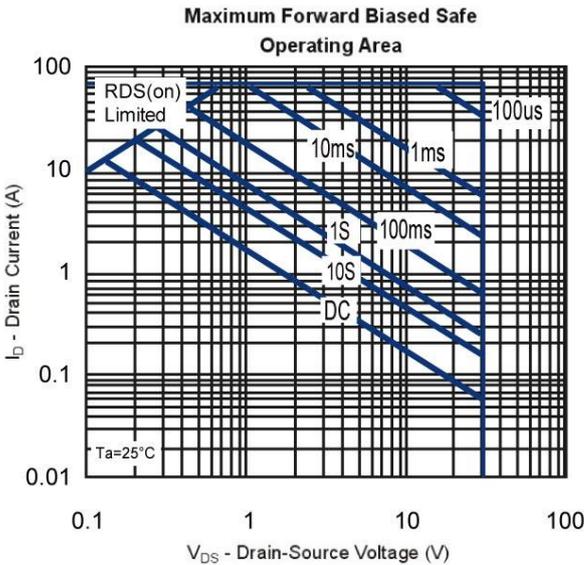
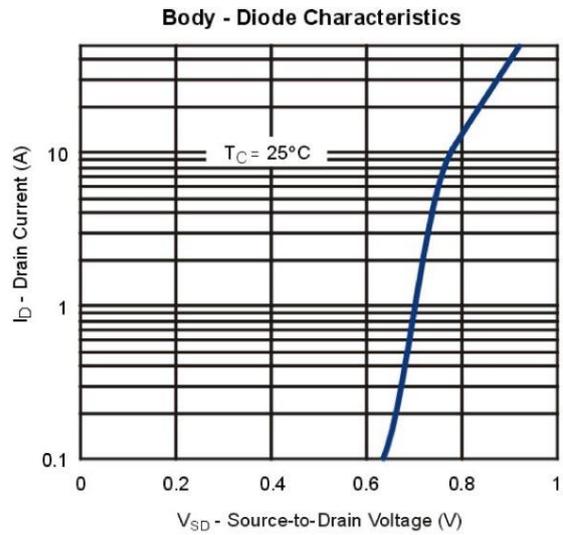
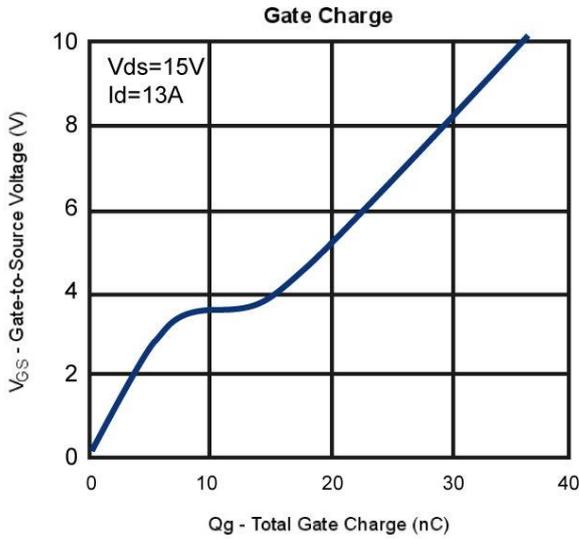
**N-Channel 30V(D-S) Enhancement MOSFET**

**Typical Characteristics (T<sub>J</sub> = 25°C Noted)**

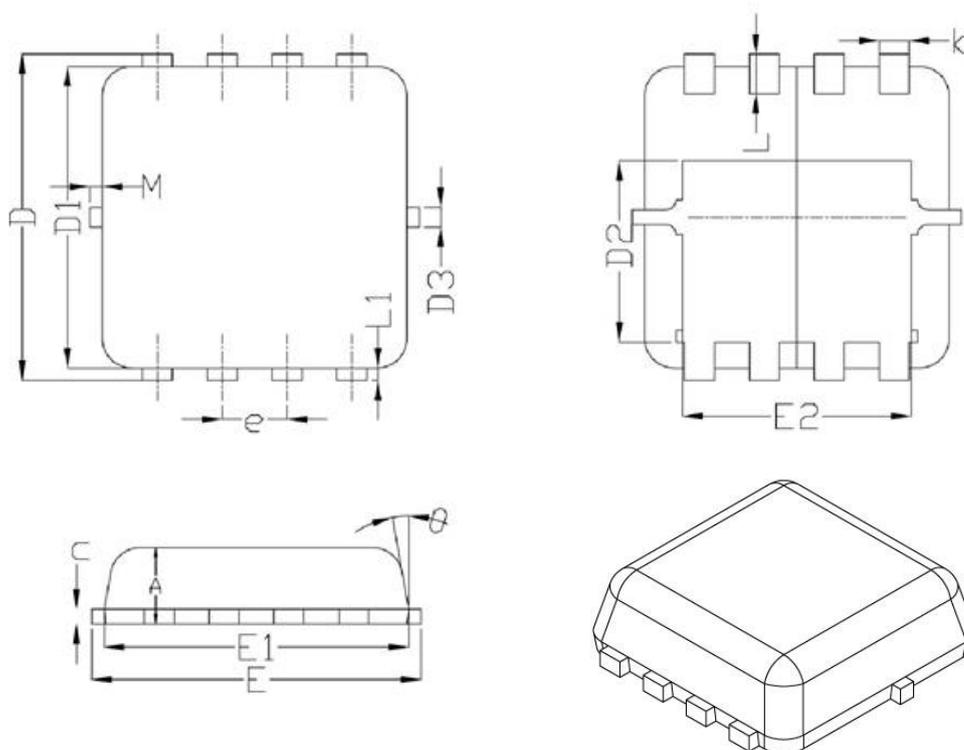


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**Typical Characteristics (T<sub>J</sub> =25°C Noted)**



**DFN(S) 3x3 Package Outline**



| SYMBOL          | DIMENSIONAL REQMTS |      |
|-----------------|--------------------|------|
|                 | MIN                | MAX  |
| A               | 0.70               | 0.90 |
| b               | 0.20               | 0.40 |
| c               | 0.08               | 0.25 |
| D               | 2.70               | 3.45 |
| D1              | 2.20               | 3.20 |
| D2              | 1.54               | 1.98 |
| D3              | 0.10               | 0.30 |
| E               | 3.15               | 3.45 |
| E1              | 2.80               | 3.30 |
| E2              | 2.25               | 2.65 |
| e               | 0.65BSC            |      |
| H               | 0.28               | 0.68 |
| L               | 0.30               | 0.50 |
| L1              | 0.06               | 0.20 |
| Θ               | ---                | 12°  |
| M               | *                  | 0.15 |
| * Not specified |                    |      |

